Figure 1: SEM micrographs of Height of CNT films grown for certain Hydrogen or water concentrations marked in figure 3. (Data bar for SEM micrographs a and b is 200µm and 100µm for c,d and e)
SI-2: Supplementary information showing SEM (a) and AFM (b) micrographs of Catalyst particles formed on Si wafer after heating up Al and Fe film on it.